

<b>Notice of References Cited</b>	Application/Control No. 10/578,685		Applicant(s)/Patent Under Reexamination BAE ET AL.	
	Examiner Rina I. Duda		Art Unit 2837	Page 1 of 1

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*	B	US-2002/0090304	07-2002	Yoo et al.	417/44.1
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